## Search Notes

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Application/Control No.	Applicant(s)/Patent Under Reexamination
10590586	HIRATA ET AL.
Examiner	Art Unit

1625

SEARCHED					
Class	Subclass	Date	Examiner		
546	268.4	3/11/2010	NC		
548	255, 181	3/11/2010	NC		

NIZAL S CHANDRAKUMAR

SEARCH NOTES				
Search Notes	Date	Examiner		
STN STRUCTURE	3/11/2010	NC		
STN INVENTOR STRUCTURE	7/2/2010	STIC		

INTERFERENCE SEARCH					
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